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INTERNATIONAL STANDARD

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BASIC EMC PUBLICATION

PUBLICATION FONDAMENTALE EN CEM

Electromagnetic compatibility (EMC) – Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic field immunity test

Compatibilité électromagnétique (CEM) – Partie 4-10: Techniques d'essai et de mesure – Essai d'immunité du champ magnétique oscillatoire amorti





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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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CONTENTS

FOREWORD	5			
INTRODUCTION	7			
1 Scope and object	8			
2 Normative references	8			
3 Terms, definitions and abbreviated terms	9			
3.1 Terms and definitions	9			
3.2 Abbreviations	10			
4 General	10			
5 Test levels	10			
6 Test instrumentation	11			
6.1 General	11			
6.2 Damped oscillatory wave generator	11			
6.2.1 General	11			
6.2.2 Performance characteristics of the generator connected to the standard induction coil	12			
6.3 Standard induction coil	14			
6.4 Calibration of the test system	14			
7 Test setup	15			
7.1 Test equipment	15			
7.2 Verification of the test instrumentation	15			
7.3 Test setup for table-top EUT	16			
7.4 Test setup for floor standing EUT	16			
7.5 Test setup for damped oscillatory field applied in-situ	18			
8 Test procedure	18			
8.1 General	18			
8.2 Laboratory reference conditions	18			
8.2.1 Climatic conditions	18			
8.2.2 Electromagnetic conditions	18			
8.3 Execution of the test				
9 Evaluation of test results	19			
10 Test report	20			
Annex A (informative) Information on the field distribution of standard induction coils	21			
A.1 General	21			
A.2 Determination of the coil factor	21			
A.2.1 General	21			
A.2.2 Coil factor calculation	21			
A.3 1 m × 1 m standard induction coil	22			
A.4 1 m \times 2,6 m standard induction coil with reference ground plane	23			
A.5 $1 \text{ m} \times 2,6 \text{ m}$ standard induction coil without reference ground plane	24			
Annex B (informative) Selection of the test levels	26			
Annex C (informative) Damped oscillatory magnetic field frequency	28			
Annex D (informative) Measurement uncertainty (MU) considerations				
D.1 General	29			
D.2 Legend	29			

D.3	Uncertainty contributors to the peak current and to the damped oscillatory magnetic field measurement uncertainty	29
D.4	Uncertainty of peak current and damped oscillatory magnetic field calibration	30
D.4.	1 General	30
D.4.:	2 Peak current	30
D.4.	3 Further MU contributions to amplitude and time measurements	32
D.4.	4 Rise time of the step response and bandwidth of the frequency response of the measuring system	32
D.4.	5 Impulse peak distortion due to the limited bandwidth of the measuring system	33
D.5	Application of uncertainties in the damped oscillatory wave generator compliance criterion	34
Annex E	(informative) 3D numerical simulations	35
E.1	General	35
E.2	Simulations	
E.3	Comments	
Bibliogra	nhv	41
Dibliogra	p., j	
Figure 1	- Simplified schematic circuit of the test generator for damped oscillatory	
magnetic	c field	12
Figure 2	- Waveform of short-circuit current in the standard coils	13
Figure 3	- Waveform of short-circuit current showing the repetition time T _{rep}	13
Figure 4	- Example of a current measurement of standard induction coils	14
Figure 5	 Example of test setup for table-top equipment 	16
Figure 6 orthogon	 Example of test setup for floor standing equipment showing the horizontal al plane 	17
Figure 7	 Example of test setup for floor standing equipment showing the vertical al plane 	17
Figure 8	 Example of test setup using the proximity method 	18
Figure A.	.1 – Rectangular induction coil with sides $a + b$ and c	22
Figure A. for the 1	$.2 - +3$ dB isoline for the magnetic field strength (magnitude) in the x-y plane m \times 1 m induction coil	22
Figure A	3 - +3 dB and -3 dB isolines for the magnetic field strength (magnitude) in	
the x - z pl	ane for the 1 m \times 1 m induction coil	23
Figure A. for the 1	.4 - +3 dB isoline for the magnetic field strength (magnitude) in the <i>x</i> - <i>z</i> plane m × 2,6 m induction coil with reference ground plane	23
Figure A. the <i>x</i> - <i>y</i> pl	$.5 - +3$ dB and -3 dB isolines for the magnetic field strength (magnitude) in lane for the 1 m \times 2,6 m induction coil with reference ground plane	24
Figure A. for the 1	$.6 - +3$ dB isoline for the magnetic field strength (magnitude) in the x-y plane m \times 2,6 m induction coil without reference ground plane	24
Figure A. the <i>x</i> - <i>z</i> pla	$.7 - +3$ dB and -3 dB isolines for the magnetic field strength (magnitude) in ane for the 1 m \times 2,6 m induction coil without reference ground plane	25
Figure E. standard	.1 – Current with period of 1 μs and H-field in the center of the 1 m \times 1 m induction coil	
Figure E.	$.2 - Hx$ -field along the side of 1 m \times 1 m standard induction coil in A/m	36
Figure E.	$.3 - Hx$ -field in direction x perpendicular to the plane of the 1 m \times 1 m induction coil	
Figure E.	$.4 - Hx$ -field along the side in dB for 1 m \times 1 m standard induction coil	37

Figure E.5 – Hx –field along the diagonal in dB for the 1 m × 1 m standard induction coil	38
Figure E.6 – Hx -field plot on <i>y</i> - <i>z</i> plane for the 1 m × 1 m standard induction coil	38
Figure E.7 – Hx -field plot on x-y plane for the 1 m × 1 m standard induction coil	39
Figure E.8 – Hx –field along the vertical middle line in dB for the 1 m × 2,6 m standard induction coil	.39
Figure E.9 – Hx -field 2D-plot on y-z plane for the 1 m × 2,6 m standard induction coil	40
Figure E.10 – Hx -field 2D-plot on x-y plane at z = 0,5 m for the 1 m × 2,6 m standard induction coil	40
Table 1 – Test levels	11
Table 2 – Peak current specifications of the test system	15
Table 3 – Waveform specifications of the test system	15

Table D.2 – α factor (see equation (D.6)) of different unidirectional impulse responses corresponding to the same bandwidth of the system <i>B</i>	Table D.1 – Example of uncertainty budget for the peak of the damped oscillatory current impulse $(I_{\rm D})$	31
Table D.3 – β factor (equation (D.12)) of the damped oscillatory waveform	Table D.2 – α factor (see equation (D.6)) of different unidirectional impulse responses corresponding to the same bandwidth of the system <i>B</i>	33
	Table D.3 – β factor (equation (D.12)) of the damped oscillatory waveform	34
	Table D.3 – β factor (equation (D.12)) of the damped oscillatory waveform	

INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTROMAGNETIC COMPATIBILITY (EMC) -

Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic field immunity test

FOREWORD

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International Standard IEC 61000-4-10 has been prepared by subcommittee 77B: High frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.

It forms Part 4-10 of the IEC 61000 series. It has the status of a basic EMC publication in accordance with IEC Guide 107.

This second edition cancels and replaces the first edition published in 1993 and Amendment 1:2000. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) new Annex A on induction coil field distribution;
- b) new Annex D on measurement uncertainty;

- c) new Annex E for numerical simulations;
- d) calibration using current measurement has been addressed in this edition.

The text of this standard is based on the following documents:

CDV	Report on voting
77B/730/CDV	77B/746A/RVC

- 6 -

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61000 series, published under the general title *Electromagnetic compatibility* (*EMC*), can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

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- withdrawn,
- replaced by a revised edition, or
- amended.

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INTRODUCTION

IEC 61000 is published in separate parts according to the following structure:

Part 1: General

General considerations (introduction, fundamental principles) Definitions, terminology

Part 2: Environment

Description of the environment

Classification of the environment

Compatibility levels

Part 3: Limits

Emission limits

Immunity limits (insofar as they do not fall under the responsibility of the product committees)

Part 4: Testing and measurement techniques

Measurement techniques

Testing techniques

Part 5: Installation and mitigation guidelines

Installation guidelines

Mitigation methods and devices

Part 6: Generic standards

Part 9: Miscellaneous

Each part is further subdivided into several parts, published either as international standards or as technical specifications or technical reports, some of which have already been published as sections. Others will be published with the part number followed by a dash and a second number identifying the subdivision (example: IEC 61000-6-1).

This part is an international standard which gives immunity requirements and test procedures related to "damped oscillatory magnetic field".

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ELECTROMAGNETIC COMPATIBILITY (EMC) -

Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic field immunity test

1 Scope and object

This part of IEC 61000 specifies the immunity requirements, test methods, and range of recommended test levels for equipment subjected to damped oscillatory magnetic disturbances related to medium voltage and high voltage sub-stations.

The test defined in this standard is applied to equipment which is intended to be installed in locations where the phenomenon as specified in Clause 4 will be encountered.

This standard does not specify disturbances due to capacitive or inductive coupling in cables or other parts of the field installation. IEC 61000-4-18, which deals with conducted disturbances, covers these aspects.

The object of this standard is to establish a common and reproducible basis for evaluating the performance of electrical and electronic equipment for medium voltage and high voltage substations when subjected to damped oscillatory magnetic fields.

The test is mainly applicable to electronic equipment to be installed in H.V. sub-stations. Power plants, switchgear installations, smart grid systems may also be applicable to this standard and may be considered by product committees.

NOTE As described in IEC Guide 107, this is a basic EMC publication for use by product committees of the IEC. As also stated in Guide 107, the IEC product committees are responsible for determining whether this immunity test standard is applied or not, and if applied, they are responsible for determining the appropriate test levels and performance criteria. TC 77 and its sub-committees are prepared to co-operate with product committees in the evaluation of the value of particular immunity test levels for their products.

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This standard defines:

- a range of test levels;
- test equipment;
- test setups;
- test procedures.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050 (all parts), International Electrotechnical Vocabulary (IEV) (available at www.electropedia.org)